## International IOR Rectifier

IRF7807VD1

FETKY™ MOSFET / SCHOTTKY DIODE

- Co-Pack N-channel HEXFET® Power MOSFET and Schottky Diode
- Ideal for Synchronous Rectifiers in DC-DC Converters Up to 5A Output
- Low Conduction Losses
- Low Switching Losses
- Low Vf Schottky Rectifier
- 100% R_G Tested

Description

The FETKY™ family of Co-Pack HEXFET®MOSFETs and Schottky diodes offers the designer an innovative, board space saving solution for switching regulator and power management applications. HEXFET power MOSFETs utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. Combining this technology with International Rectifier's low forward drop Schottky rectifiers results in an extremely efficient device suitable for use in a wide variety of portable electronics applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics. The SO-8 package is designed for vapor phase, infrared or wave soldering techniques.

SO-8

Top View
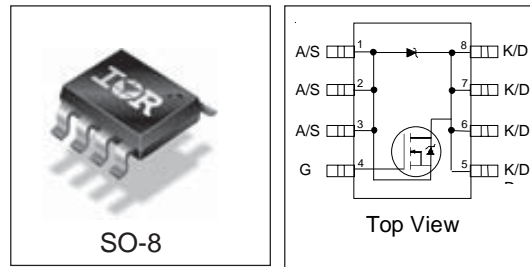
DEVICE CHARACTERISTICS⑤

	IRF7807VD1
$R_{DS(on)}$	17mΩ
Q_G	9.5nC
Q_{sw}	3.4nC
Q_{oss}	12nC

Absolute Maximum Ratings

Parameter		Symbol	Max	Units
Drain-to-Source Voltage		V_{DS}	30	V
Gate-to-Source Voltage		V_{GS}	±20	
Continuous Output Current	25°C	I_D	8.3	A
($V_{GS} \geq 4.5V$)	70°C		6.6	
Pulsed Drain Current ①		I_{DM}	66	
Power Dissipation ③	25°C	P_D	2.5	W
	70°C		1.6	
Schottky and Body Diode	25°C	I_F (AV)	3.5	
Average Forward Current ④	70°C		2.2	
Junction & Storage Temperature Range		T_J , T_{STG}	-55 to 150	°C

Thermal Resistance

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ③ ⑥	$R_{\theta JA}$	——	50	°C/W
Maximum Junction-to-Lead ⑥	$R_{\theta JL}$	——	20	

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Electrical Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	30	——	——	V	$V_{GS} = 0V$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	$R_{DS(on)}$	——	17	25	mΩ	$V_{GS} = 4.5V$, $I_D = 7.0A$ ②
Gate Threshold Voltage	$V_{GS(th)}$	1.0	——	3.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Drain-Source Leakage Current	I_{DSS}	——	——	100	µA	$V_{DS} = 30V$, $V_{GS} = 0V$
		——	——	20	µA	$V_{DS} = 24V$, $V_{GS} = 0V$
		——	——	2.0	mA	$V_{DS} = 24V$, $V_{GS} = 0V$, $T_J = 100°C$
Gate-Source Leakage Current	I_{GSS}	——	——	±100	nA	$V_{GS} = \pm 20V$
Total Gate Charge*	Q_G	——	9.5	14	nC	$V_{DS} = 4.5V$ $I_D = 7.0A$ $V_{DS} = 16V$
Pre-Vth Gate-Source Charge	Q_{GS1}	——	2.3	——		
Post-Vth Gate-Source Charge	Q_{GS2}	——	1.0	——		
Gate-to-Drain Charge	Q_{GD}	——	2.4	——		
Switch Charge ($Q_{gs2} + Q_{gd}$)	Q_{SW}	——	3.4	5.2		
Output Charge*	Q_{OSS}	——	12	16.8		$V_{DS} = 16V$, $V_{GS} = 0$
Gate Resistance	R_G	0.9	——	2.8	Ω	
Turn-On Delay Time	$t_{d(on)}$	——	6.3	——	ns	$V_{DD} = 16V$, $I_D = 7.0V$ $V_{GS} = 5V$, $R_G = 2\Omega$ Resistive Load
Rise Time	t_r	——	1.2	——		
Turn-Off Delay Time	$t_{d(off)}$	——	11	——		
Fall Time	t_f	——	2.2	——		

Diode Characteristics

Parameter	Symbol	Min	Typ	Max	Units	Conditions
Diode Forward Voltage	V_{SD}	——	——	0.5	V	$T_J = 25°C$, $I_S = 1.0A$, $V_{GS} = 0V$②
		——	——	0.39		$T = 125°C$, $I_S = 1.0A$, $V_{GS} = OV$②
Reverse Recovery Time ④	t_{rr}	——	51	——	ns	$di/dt = 700A/\mu s$ $V_{DD} = 16V$, $V_{GS} = 0V$, $I_D = 15A$
Reverse Recovery Charge ④	Q_{rr}	——	51	——	nC	$T_J = 25°C$, $I_S = 7.0A$, $V_{DS} = 16V$ $di/dt = 100A/\mu s$

Notes:
① Repetitive rating; pulse width limited by max. junction temperature.
② Pulse width ≤ 400 µs; duty cycle ≤ 2%.
③ When mounted on 1 inch square copper board
④ 50% Duty Cycle, Rectangular
⑤ Typical values of R_{DS}(on) measured at $V_{GS} = 4.5V$, Q_G, Q_{SW} and Q_{OSS} measured at $V_{GS} = 5.0V$, $I_F = 7.0A$.
⑥ R_θ is measured at T_J approximately 90°C
* Device are 100% tested to these parameters.

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Power MOSFET Selection for DC/DC Converters

Control FET

Special attention has been given to the power losses in the switching elements of the circuit - Q1 and Q2. Power losses in the high side switch Q1, also called the Control FET, are impacted by the $R_{ds(on)}$ of the MOSFET, but these conduction losses are only about one half of the total losses.

Power losses in the control switch Q1 are given by;

$$P_{loss} = P_{conduction} + P_{switching} + P_{drive} + P_{output}$$

This can be expanded and approximated by;

$$P_{loss} = \left(I_{rms}^{\ 2} \times R_{ds(on)} \right)$$
$$+ \left(I \times \frac{Q_{gd}}{i_g} \times V_{in} \times f \right) + \left(I \times \frac{Q_{gs2}}{i_g} \times V_{in} \times f \right)$$
$$+ \left(Q_g \times V_g \times f \right)$$
$$+ \left(\frac{Q_{oss}}{2} \times V_{in} \times f \right)$$

This simplified loss equation includes the terms Q_{gs2} and Q_{oss} which are new to Power MOSFET data sheets.

Q_{gs2} is a sub element of traditional gate-source charge that is included in all MOSFET data sheets. The importance of splitting this gate-source charge into two sub elements, Q_{gs1} and Q_{gs2}, can be seen from Fig 1.

Q_{gs2} indicates the charge that must be supplied by the gate driver between the time that the threshold voltage has been reached (t1) and the time the drain current rises to I_{dmax} (t2) at which time the drain voltage begins to change. Minimizing Q_{gs2} is a critical factor in reducing switching losses in Q1.

Q_{oss} is the charge that must be supplied to the output capacitance of the MOSFET during every switching cycle. Figure 2 shows how Q_{oss} is formed by the parallel combination of the voltage dependant (non-linear) capacitance's C_{ds} and C_{dg} when multiplied by the power supply input buss voltage.
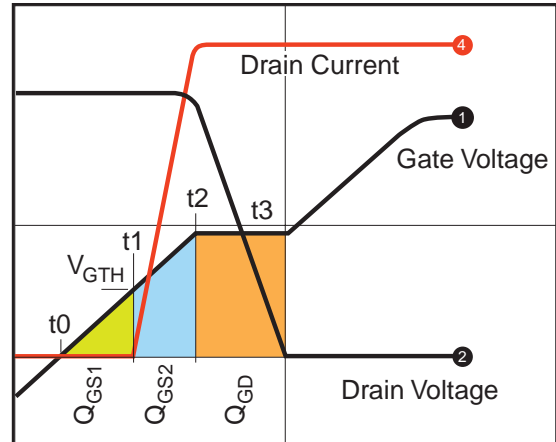
Figure 1: Typical MOSFET switching waveform

Synchronous FET

The power loss equation for Q2 is approximated by;

$$P_{loss} = P_{conduction} + P_{drive} + P_{output}^*$$

$$P_{loss} = \left(I_{rms}^{\ 2} \times R_{ds(on)} \right)$$
$$+ \left(Q_g \times V_g \times f \right)$$
$$+ \left(\frac{Q_{oss}}{2} \times V_{in} \times f \right) + \left(Q_{rr} \times V_{in} \times f \right)$$

*dissipated primarily in Q1.

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For the synchronous MOSFET Q2, $R_{ds(on)}$ is an important characteristic; however, once again the importance of gate charge must not be overlooked since it impacts three critical areas. Under light load the MOSFET must still be turned on and off by the control IC so the gate drive losses become much more significant. Secondly, the output charge Q_{oss} and reverse recovery charge Q_{rr} both generate losses that are transfered to Q1 and increase the dissipation in that device. Thirdly, gate charge will impact the MOSFETs' susceptibility to Cdv/dt turn on.

The drain of Q2 is connected to the switching node of the converter and therefore sees transitions between ground and V_{in}. As Q1 turns on and off there is a rate of change of drain voltage dV/dt which is capacitively coupled to the gate of Q2 and can induce a voltage spike on the gate that is sufficient to turn

the MOSFET on, resulting in shoot-through current . The ratio of Q_{gd}/Q_{gs1} must be minimized to reduce the potential for Cdv/dt turn on.

Spice model for IRF7807V can be downloaded in machine readable format at www.irf.com.

$$C_{oss} = C_{dg} + C_{ds}$$
$$\Delta Q_{oss} = C_{oss} \times \Delta V_{in}$$
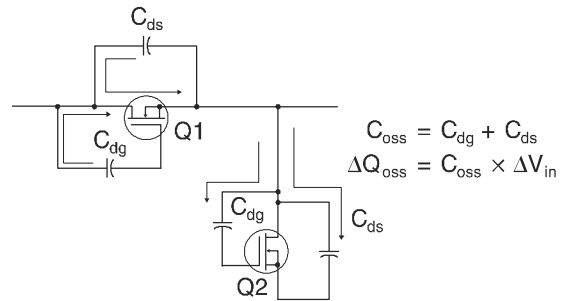
Figure 2: Q_{oss} Characteristic

Typical Mobile PC Application

The performance of these new devices has been tested in circuit and correlates well with performance predictions generated by the system models. An advantage of this new technology platform is that the MOSFETs it produces are suitable for both control FET and synchronous FET applications. This has been demonstrated with the 3.3V and 5V converters. (Fig 3 and Fig 4). In these applications the same MOSFET IRF7807V was used for both the control FET (Q1) and the synchronous FET (Q2). This provides a highly effective cost/performance solution.
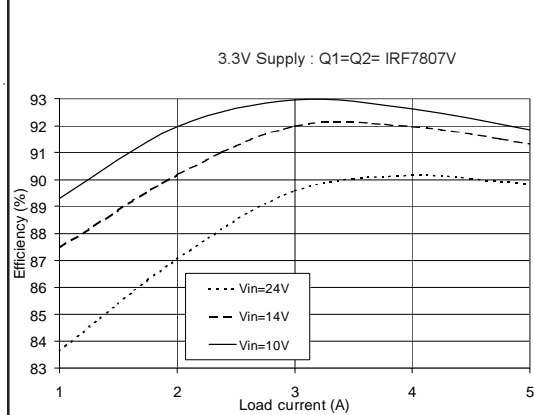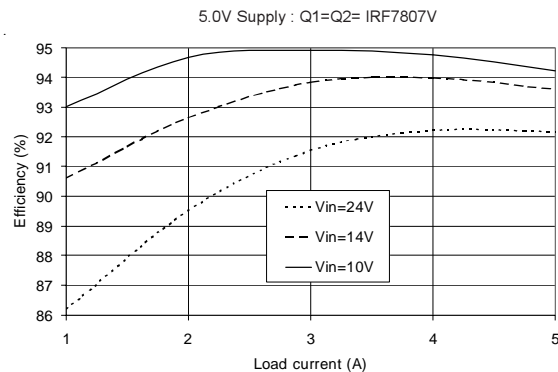

3.3V Supply : Q1=Q2= IRF7807V

Vin=24V
Vin=14V
Vin=10V

Figure 3

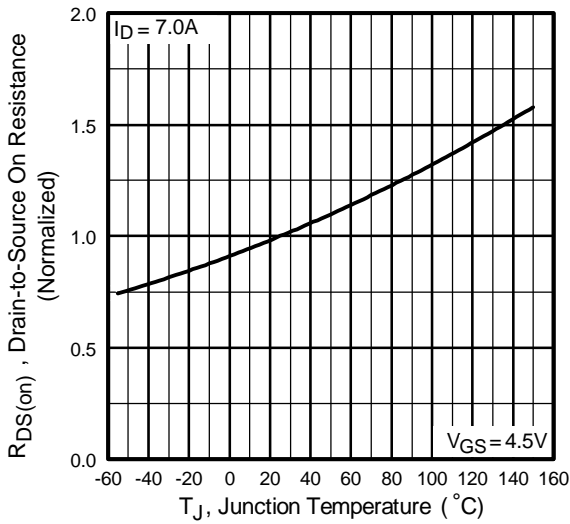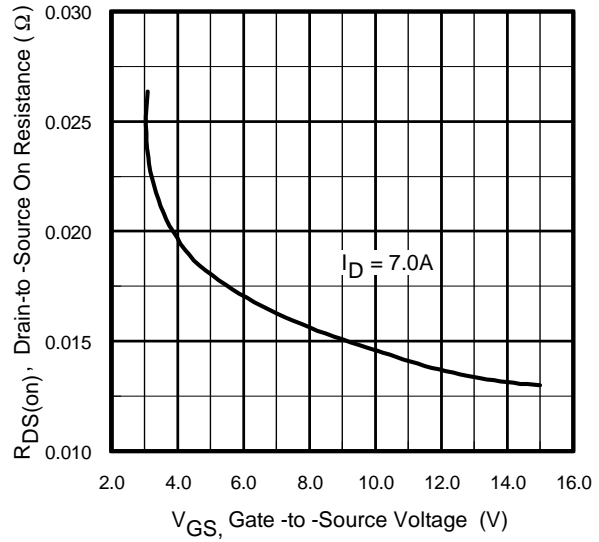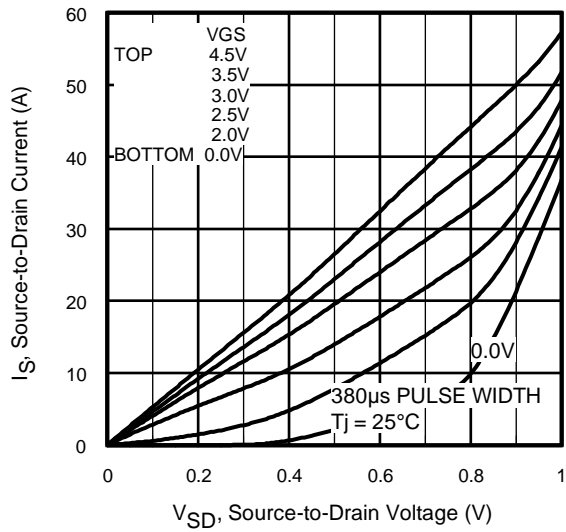5.0V Supply : Q1=Q2= IRF7807V

Vin=24V
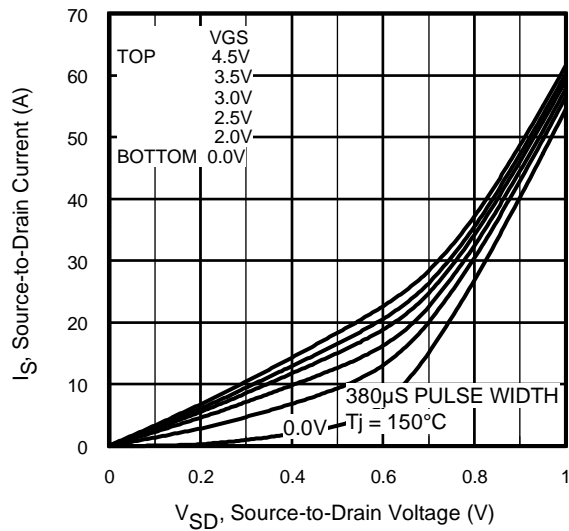Vin=14V
Vin=10V

Figure 4

Fig 5. Normalized On-Resistance
Vs. Temperature

Fig 7. On-Resistance Vs. Gate Voltage

Fig 7. Typical Reverse Output Characteristics

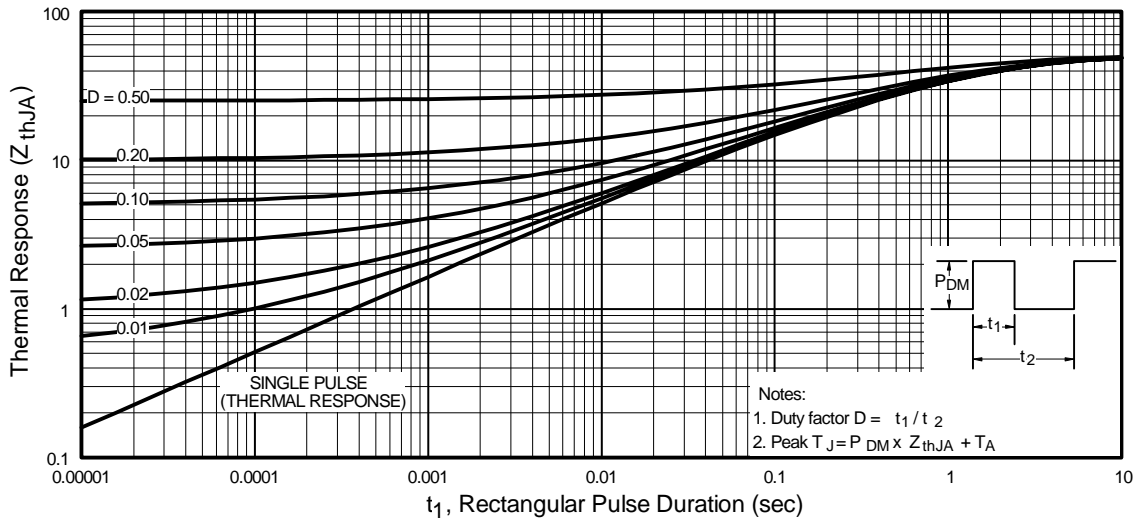**Fig 8.** Typical Reverse Output Characteristics

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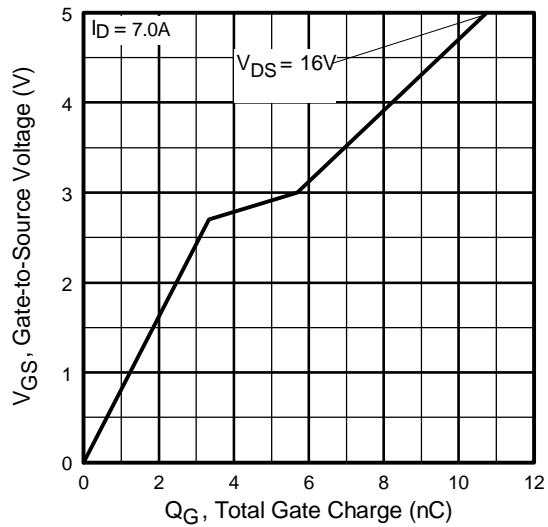Figure 9. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient
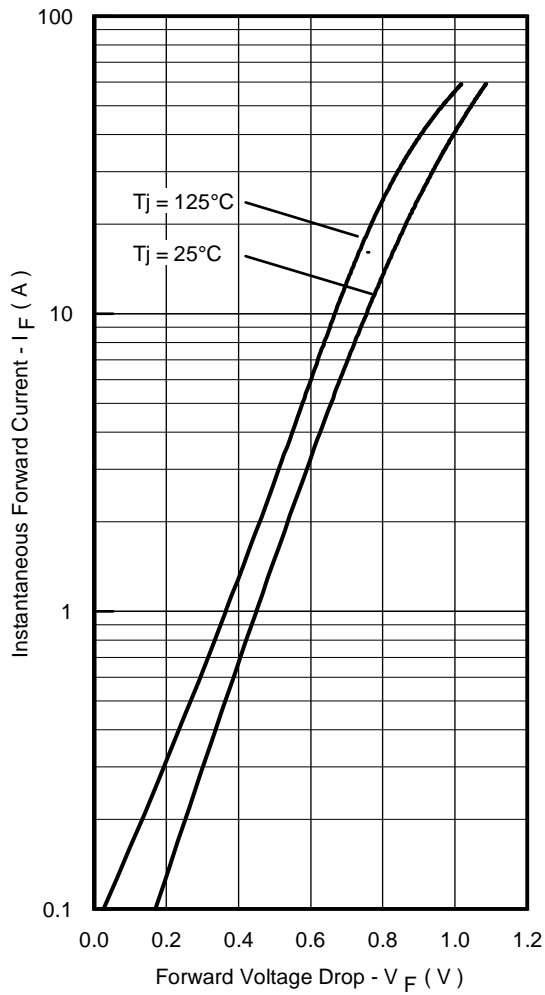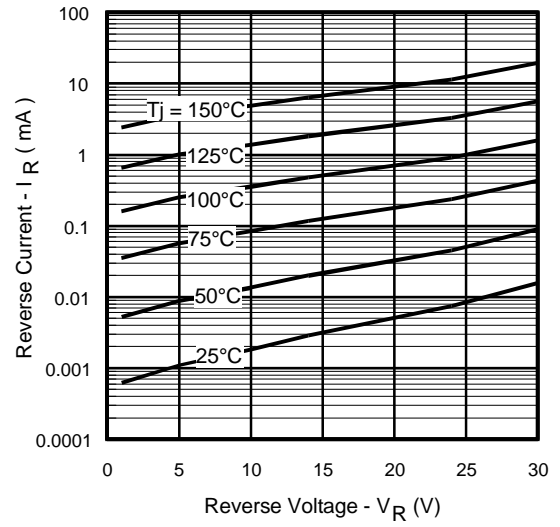

Fig 10. Typical Gate Charge Vs. Gate-to-Source Voltage

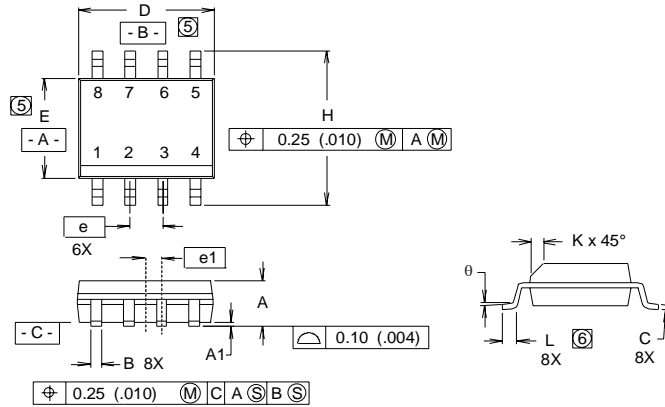## MOSFET , Body Diode & Schottky Diode Characteristics

Fig. 11 - Typical Forward Voltage Drop Characteristics

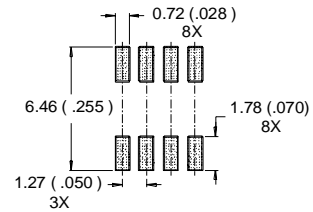**Fig. 12** - Typical Values of Reverse Current Vs. Reverse Voltage

IRF7807VD1

SO-8 Package Details

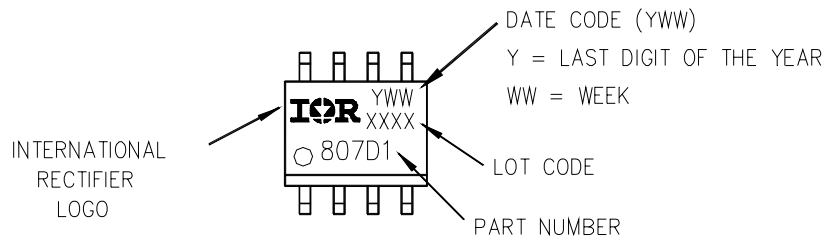| DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
B	.014	.018	0.36	0.46
C	.0075	.0098	0.19	0.25
D	.189	.196	4.80	4.98
E	.150	.157	3.81	3.99
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.011	.019	0.28	0.48
L	0.16	.050	0.41	1.27
θ	0°	8°	0°	8°

RECOMMENDED FOOTPRINT

NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1982.
2. CONTROLLING DIMENSION : INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5 DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS
   MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.006).
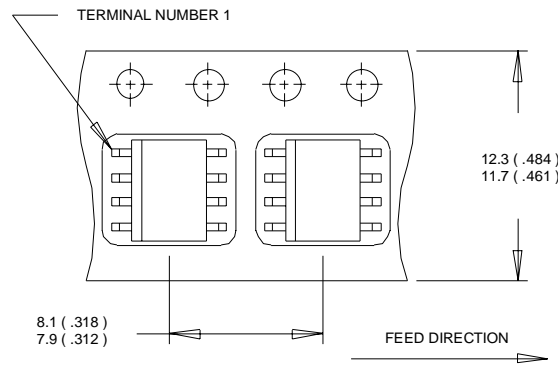6 DIMENSIONS IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE..

SO-8 Part Marking

SO-8 (MS-012AA)

EXAMPLE: THIS IS AN IRF7807D1 (FETKY)

INTERNATIONAL
RECTIFIER
LOGO

DATE CODE (YWW)
Y = LAST DIGIT OF THE YEAR
WW = WEEK

LOT CODE

PART NUMBER

SO-8 Tape and Reel

TERMINAL NUMBER 1

12.3 (.484)
11.7 (.461)

8.1 (.318)
7.9 (.312)

FEED DIRECTION

NOTES:
1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.

$\varnothing$ 330.00
(12.992)
MAX.

14.40 (.566)
12.40 (.488)
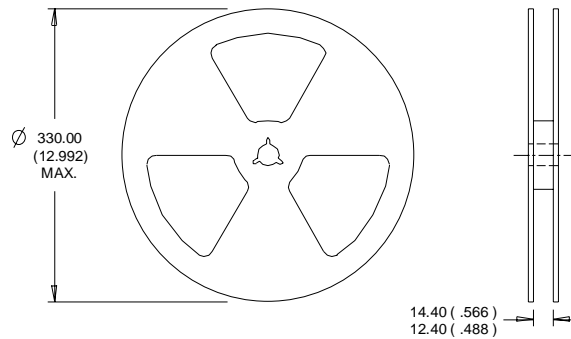
NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

This product has been designed and qualified for the commercial market.
Qualification Standards can be found on IR's Web site.

International **IƠR** Rectifier

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Visit us at www.irf.com for sales contact information**.** 10/03